

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/825,871 CHANG, SEN-TAY	
		Examiner	Art Unit Caridad M. Everhart	2891 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0065645	04-2004	Welch et al.	219/121.43
	B	US-			
	C	US-			
	D	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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